

An efficient $i\mathcal{O}$ -based data integrity verification scheme for cloud storage

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Appendix A Indistinguishability obfuscation

Definition 1 (Indistinguishability Obfuscation). Given a family of polynomial-size circuits $\mathcal{C} = \{\mathcal{C}_\lambda\}_{\lambda \in \mathbb{N}}$, an indistinguishability obfuscator for the circuit class $\{\mathcal{C}_\lambda\}$ is defined as a uniform PPT machine $i\mathcal{O}$ that satisfies the following conditions:

- (Preserving Functionality) For all security parameters $\lambda \in \mathbb{N}$, for all $C \in \mathcal{C}_\lambda$, for all inputs x , we have that $\Pr[C'(x) = C(x) : C' \leftarrow i\mathcal{O}(\lambda, C)] = 1$.

- (Indistinguishability of Obfuscation) For any (not necessarily uniform) PPT distinguisher $\mathcal{B} = (\text{Samp}, D)$, there exists a negligible function $\text{negl}(\cdot)$ such that the following holds: if for all security parameters $\lambda \in \mathbb{N}$, $\Pr[\forall x, C_0(x) = C_1(x) : (C_0; C_1; \sigma) \leftarrow \text{Samp}(1^\lambda)] > 1 - \text{negl}(\lambda)$, then we have

$$\begin{aligned} & |\Pr[D(\sigma, i\mathcal{O}(\lambda, C_0)) = 1 : (C_0; C_1; \sigma) \leftarrow \text{Samp}(1^\lambda)] - \\ & \Pr[D(\sigma, i\mathcal{O}(\lambda, C_1)) = 1 : (C_0; C_1; \sigma) \leftarrow \text{Samp}(1^\lambda)]| \leq \text{negl}(\lambda). \end{aligned}$$

Appendix B Puncturable pseudorandom functions

A puncturable pseudorandom function (PRF) is evaluated at all bit strings of a certain length. It is defined by two PPT algorithms $(\text{Eval}_F, \text{Puncture}_F)$ that satisfy the following conditions:

- (Functionality preserved under puncturing) For every PPT algorithm \mathcal{K} with input 1^λ outputs a set $S \subseteq \{0, 1\}^n$, for all $x \in \{0, 1\}^n \setminus S$, we have $\Pr[\text{Eval}_F(K\{S}, x) = F(K, x) : K \xleftarrow{\$} \mathcal{K}, K\{S} \leftarrow \text{Puncture}_F(K, S)] = 1$.

- (Pseudorandom at punctured points) For every pair of PPT algorithms $(\mathcal{A}_1, \mathcal{A}_2)$ such that $\mathcal{A}_1(1^\lambda)$ outputs a set $S \subseteq \{0, 1\}^n$ and a state σ , consider an experiment where $K \xleftarrow{\$} \mathcal{K}, K\{S} \leftarrow \text{Puncture}_F(K, S)$. Let U_l denotes the uniform distribution over l bits. Then we have

$$\begin{aligned} & |\Pr[\mathcal{A}_2(\sigma, K\{S}, S, \text{Eval}_F(K, S)) = 1] - \\ & \Pr[\mathcal{A}_2(\sigma, K\{S}, S, U_{m(\lambda) \cdot |S|}) = 1]| \leq \text{negl}(\lambda). \end{aligned}$$

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